

P-Channel 30-V (D-S) MOSFET

PRODUCT SUMMARY				
V _{DS} (V)	R _{DS(on)} (Ω)	I _D (A) ^d	Q _g (Typ.)	
- 30	0.038 at V _{GS} = - 10 V	- 15	29.5 nC	
	0.062 at V _{GS} = - 4.5 V	- 11	29.5110	

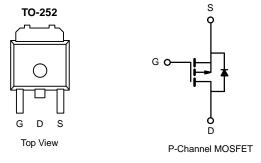
FEATURES

- DT-Trench Power MOSFET
- 100 % R_g Tested
- 100 % UIS Tested

APPLICATIONS

- Load Switch
- Notebook Adaptor Switch





Parameter	Symbol	Limit	Unit	
Drain-Source Voltage	V _{DS}	- 30	V	
Gate-Source Voltage		V _{GS}	± 20	v
	T _C = 25 °C		- 15	
Continuous Drain Current (T _{.1} = 150 °C)	T _C = 70 °C		- 11	
Continuous Drain Current $(T_j = 150 \text{ C})$	T _A = 25 °C	I _D	- 10 ^{a, b}	
	T _A = 70 °C		- 8.6 ^{a, b}	_
Pulsed Drain Current		I _{DM}	- 60	Α
Outline Outline David Dia to Outline of	T _C = 25 °C		- 14	
Continuous Source-Drain Diode Current	T _A = 25 °C	Is Is	- 7 ^{a, b}	
Avalanche Current		I _{AS}	- 15	
Single-Pulse Avalanche Energy L = 0.1 mH		E _{AS}	20	mJ
	T _C = 25 °C		5.0	
Mariana David Diasia dia d	T _C = 70 °C	P.	3.2	w
Maximum Power Dissipation	T _A = 25 °C	– P _D –	2.7 ^{a, b}	vv
	T _A = 70 °C	1	1.7 ^{a, b}	
Operating Junction and Storage Temperature Rang	T _J , T _{stq}	- 55 to 150	°C	

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient ^{a, c}	t ≤ 10 s	R _{thJA}	38	46	°C/W	
Maximum Junction-to-Foot	Steady State	R _{thJF}	20	25	C/VV	

Notes:

b. t = 10 s.

- c. Maximum under Steady State conditions is 85 $^{\circ}\text{C/W}.$
- d. Based on T_C = 25 °C.

a. Surface mounted on 1" x 1" FR4 board.

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SPECIFICATIONS T _J = 25 °C, unless otherwise noted							
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static				1		1	
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 V, I_D = -250 \mu A$	- 30			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I _D = - 250 μA		- 34		mV/ °C	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	5 1		5.3			
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = -250 \ \mu A$	- 1.0		- 3.0	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 V, V_{GS} = \pm 20 V$			± 100	nA	
Zero Gate Voltage Drain Current	lass	$V_{DS} = -24 V, V_{GS} = 0 V$			- 1		
	IDSS	$V_{DS} = -24 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 \text{ °C}$			- 5	μA	
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge -10 \text{ V}, \text{ V}_{GS} = -10 \text{ V}$	- 15			Α	
	D	V _{GS} = - 10 V, I _D = - 10 A		0.038	0.048	0	
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = - 4.5 V, I _D = - 8 A		0.062	0.075	Ω	
Forward Transconductance ^a	9 _{fs}	V _{DS} = - 24 V, I _D = - 10 A		28		S	
Dynamic ^b						•	
Input Capacitance	C _{iss}			2550			
Output Capacitance	C _{oss}	V _{DS} = - 24 V, V _{GS} = 0 V, f = 1 MHz		455		pF	
Reverse Transfer Capacitance	C _{rss}			390			
		V _{DS} = - 24 V, V _{GS} = - 10 V, I _D = - 10 A		57	86		
Total Gate Charge	Q _g		29.5	45	_		
Gate-Source Charge	Q _{qs}	Q_{gs} V _{DS} = - 24 V, V _{GS} = - 4.5 V, I _D = - 10 A		8		nC	
Gate-Drain Charge	Q _{gd}			22			
Gate Resistance	R _q	f = 1 MHz	0.5	2.2	4.4	Ω	
Turn-On Delay Time	t _{d(on)}			13	25		
Rise Time	t _r	$V_{DD} = -24 \text{ V}, \text{ R}_{1} = 1.5 \Omega$		12	24	-	
Turn-Off DelayTime	t _{d(off)}	$I_D \cong -10 \text{ A}, \text{ V}_{\text{GEN}} = -10 \text{ V}, \text{ R}_{\text{g}} = 1 \Omega$		40	70		
Fall Time	t _f			9	18		
Turn-On Delay Time	t _{d(on)}			48	80	ns	
Rise Time	t _r	$V_{DD} = -24 \text{ V}, \text{ R}_{1} = 1.5 \Omega$		92	160	-	
Turn-Off DelayTime	t _{d(off)}	$I_D \cong$ - 10 Å, V_{GEN} = - 4.5 V, R_q = 1 Ω		34	60		
Fall Time	t _f	5 52.0 9		19	35		
Drain-Source Body Diode Characteris				-	-		
Continous Source-Drain Diode Current	Is	T _C = 25 °C			- 15		
Pulse Diode Forward Current	I _{SM}	6			- 60	A	
Body Diode Voltage	V _{SD}	I _S = - 3 A, V _{GS} = 0 V		- 0.75	- 1.2	V	
Body Diode Reverse Recovery Time	t _{rr}	<u> </u>		27	45	ns	
Body Diode Reverse Recovery Charge	Q _{rr}	1		16	27	nC	
Body block reverse receivery onlargedrrfReverse Recovery Fall Timeta		I _F = - 10 A, dl/dt = 100 A/μs, T _J = 25 °C		10			
Reverse Recovery Rise Time	t _b		ns				

Notes:

a. Pulse test; pulse width \leq 300 $\mu s,$ duty cycle \leq 2 %.

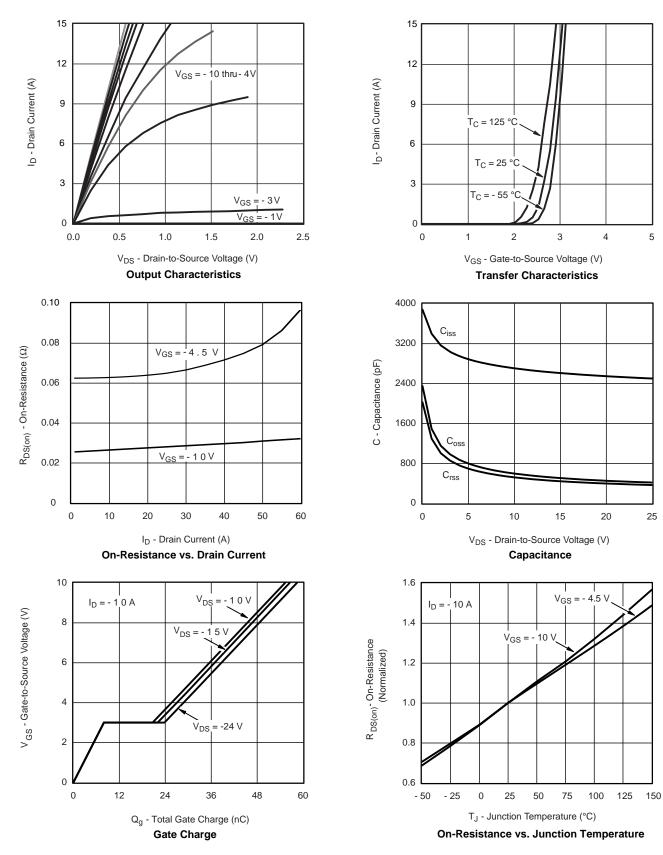
b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



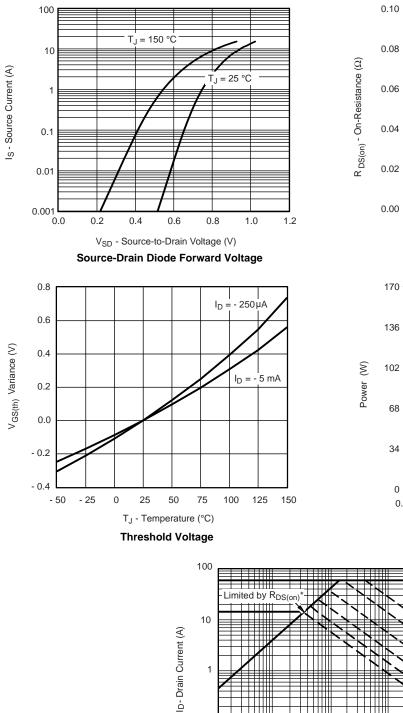
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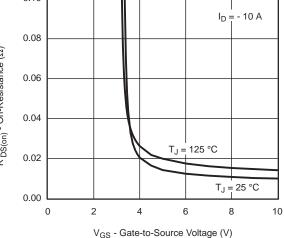
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



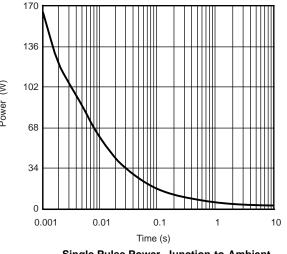
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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

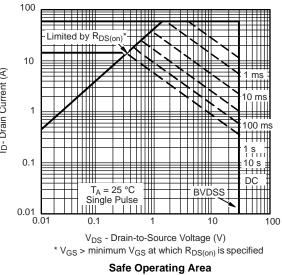




On-Resistance vs. Gate-to-Source Voltage

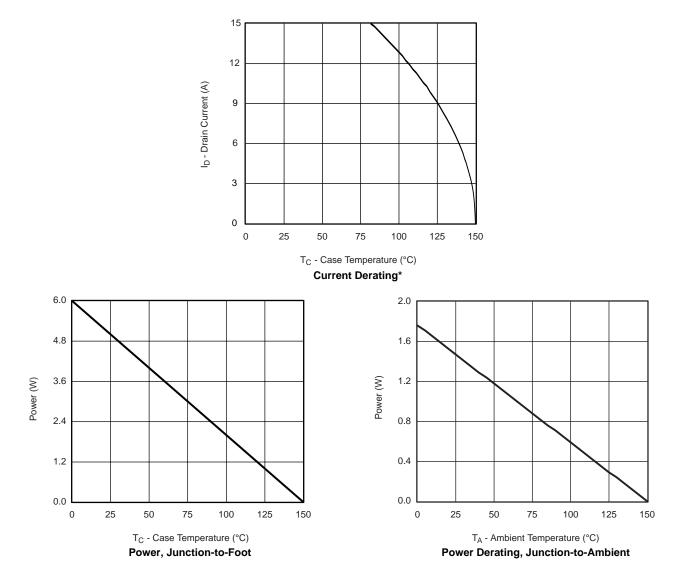


Single Pulse Power, Junction-to-Ambient





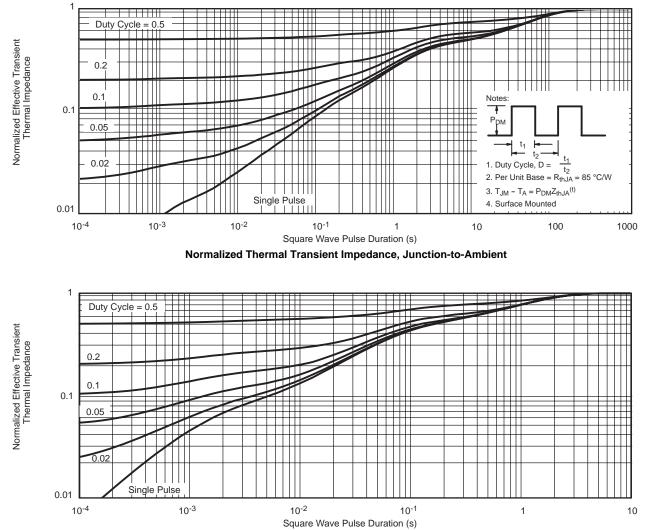
MOSFET TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



* The power dissipation P_D is based on $T_{J(max)}$ = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

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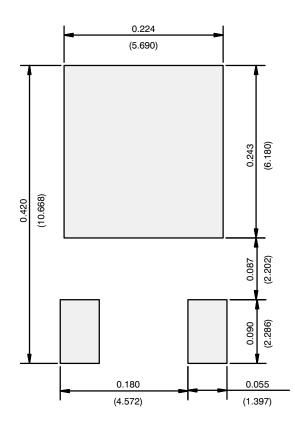




Normalized Thermal Transient Impedance, Junction-to-Foot



RECOMMENDED MINIMUM PADS FOR DPAK (TO-252)



Recommended Minimum Pads Dimensions in Inches/(mm)

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